

<b>Notice of Reference <i>Cited</i></b>	Application/Control No. <b>09/964,071</b>	Applicant(s)/Patent Under Reexam <b>Jedlitschka</b>
	Examiner <b>Tuyen T. Nguyen</b>	Art Unit <b>2832</b>
		Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,847,947	12/1998	Pan et al.	336	200
B	4,641,118	2/1987	Hirose et al.	336	200
C					
D					
E					
F					
G					
H					
I					
J					
K					
L					
M					

**FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N	56-98805	8/1981	JP	---	---	---
O						
P						
Q						
R						
S						
T						

**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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